

Notice of References Cited

Application/Control No.

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Applicant(s)/Patent Under
Reexamination
TANAKA, SHIN-ICHI

Examiner

Heather Beegle

Art Unit

4137

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,611,819	08-2003	Oneda, Hideo	705/41
	B	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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